

<b>Notice of References Cited</b>	Application/Control No. 10/552,311	Applicant(s)/Patent Under Reexamination OONK ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0072140	04-2005	Taylor et al.	060/295
*	C	US-2006/0292051	12-2006	Sekiba et al.	423/213.5
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	K	US-			
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**NON-PATENT DOCUMENTS**

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